Product Change Notification - KSRA-26CDAN357

Date: 03 Apr 2017 **Product Category:** Memory

Notification subject: CCB 2897 Final Notice: Qualification of palladium coated copper with gold flash (CuPdAu) bond

wire in selected products of the 150K wafer technology available in 8L TDFN package at NSEB

assembly site.

Notification text: PCN Status: Final notification

Microchip Parts Affected:

Please open the attachments found in the attachments field below labeled as PCN_#_Affected_CPN.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:

Qualification of palladium coated copper with gold flash (CuPdAu) bond wire in selected products of the 150K wafer technology available in 8L TDFN package at NSEB assembly site.

Pre Change:

Using gold (Au) bond wire, 8200T die attach and G770HCD mold compound material.

Post Change:

Using palladium coated copper with gold flash (CuPdAu) bond wire, 8600 die attach and G700LTD mold compound material.

Pre and Post Change Summary:

| | Pre Change | Post Change | | |
|---------------------------|--------------------|--------------------|--|--|
| | 11055 | 11055 | | |
| Assembly Site | NSEB assembly site | NSEB assembly site | | |
| Wire material | Au wire | CuPdAu wire | | |
| Die attach material | 8200T | 8600 | | |
| Molding compound material | G770HCD | G700LTD | | |
| Lead frame material | C194 | C194 | | |

Impacts to Data Sheet:

None

Change Impact:

None

Reason for Change:

To improve manufacturability and qualify CuPdAu bond wire, 8600 die attach and G700LTD mold compound material at NSEB assembly site.

Change Implementation Status:

In Progress

Estimated First Ship Date:

May 15, 2017

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

| | | March 2017 | | | | > | May 2017 | | | | |
|-------------------------------------|----|------------|----|----|----|---|----------|----|----|----|----|
| Workweek | 09 | 10 | 11 | 12 | 13 | | 18 | 19 | 20 | 21 | 32 |
| Final PCN Issue Date | | | | | x | | | | | | |
| Estimated Implementation Date | | | | | | | | | Х | | |

Method to Identify Change:

Traceability code

Qualification Report:

Please open the attachments included with this PCN labeled as PCN_#_Qual Report.

Revision History:

March 31, 2017: Issued final notification.

April 3, 2017: Re-issued final notification to revise the qual report title.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachment(s): PCN_KSRA-26CDAN357_Qual Report.pdf

PCN_KSRA-26CDAN357_Affected CPN.pdf PCN_KSRA-26CDAN357_Affected CPN.xlsx

Please contact your local Microchip sales office with questions or concerns regarding this notification.

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Affected Catalog Part Numbers (CPN)

| PCN KSRA-26CDAN357 |
|--------------------|
| CATALOG_PART_NBR |
| 24AA32AT-I/MNY |
| 24LC32AT-I/MNY |
| 93AA46AT-I/MNY |
| 93AA46BT-I/MNY |
| 93AA46CT-I/MNY |
| 93AA56AT-I/MNY |
| 93AA56BT-I/MNY |
| 93AA56CT-I/MNY |
| 93AA66AT-I/MNY |
| 93AA66BT-I/MNY |
| 93AA66CT-I/MNY |
| 93AA76CT-I/MNY |
| 93AA86CT-I/MNY |
| 93C46AT-E/MNY |
| 93C46AT-I/MNY |
| 93C46BT-E/MNY |
| 93C46BT-I/MNY |
| 93C46CT-E/MNY |
| 93C46CT-I/MNY |
| 93C56AT-E/MNY |
| 93C56AT-I/MNY |
| 93C56BT-E/MNY |
| 93C56BT-I/MNY |
| 93C56CT-E/MNY |
| 93C56CT-I/MNY |
| 93C66AT-E/MNY |
| 93C66AT-I/MNY |
| 93C66BT-E/MNY |
| 93C66BT-I/MNY |
| 93C66CT-E/MNY |
| 93C66CT-I/MNY |
| 93C76CT-E/MNY |
| 93C76CT-I/MNY |
| 93C86CT-E/MNY |
| 93C86CT-I/MNY |
| 93LC46AT-E/MNY |
| 93LC46AT-I/MNY |
| 93LC46BT-E/MNY |
| 93LC46BT-I/MNY |
| 93LC46CT-E/MNY |
| 93LC46CT-I/MNY |
| 93LC56AT-E/MNY |
| 93LC56AT-I/MNY |

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Affected Catalog Part Numbers (CPN)

| PCN_KSRA-26CDAN357 |
|--------------------|
| CATALOG_PART_NBR |
| 93LC56BT-E/MNY |
| 93LC56BT-I/MNY |
| 93LC56CT-E/MNY |
| 93LC56CT-I/MNY |
| 93LC66AT-E/MNY |
| 93LC66AT-I/MNY |
| 93LC66BT-E/MNY |
| 93LC66BT-I/MNY |
| 93LC66CT-E/MNY |
| 93LC66CT-I/MNY |
| 93LC76CT-E/MNY |
| 93LC76CT-I/MNY |
| 93LC86CT-E/MNY |
| 93LC86CT-I/MNY |